

# Revision History 128Mb AS4C4M32D1A - 144 ball FBGA PACKAGE

Revision	Details	Date
Rev 1.0	Preliminary datasheet	May. 2016

Alliance Memory Inc. 511 Taylor Way, San Carlos, CA 94070 TEL: (650) 610-6800 FAX: (650) 620-9211 Alliance Memory Inc. reserves the right to change products or specification without notice

Confidential - 1/64 - Rev.1.0 May 2016



#### **Features**

- Fast clock rate: 200 MHz
- Differential Clock CK & CK input
- 4 Bi-directional DQS. Data transactions on both edges of DQS (1DQS / Byte)
- DLL aligns DQ and DQS transitions
- · Edge aligned data & DQS output
- Center aligned data & DQS inpu
- 4 internal banks, 1M x 32-bit for each bank
- Programmable mode and extended mode registers
  - CAS Latency: 2, 2.5, 3
  - Burst length: 2, 4, 8
  - Burst Type: Sequential & Interleave
- All inputs except DQ's & DM are at the positive edge of the system clock
- 4 individual DM control for write masking only
- · Auto Refresh and Self Refresh
- 4096 refresh cycles / 64ms
- Operating Temperature:
  - Industrial -40°C~85°C
  - Commercial 0°C to 70°C
- Power supplies: VDD & VDDQ = 2.5V ± 0.2V
- Interface: SSTL\_2 I/O compatible
- 144-ball 12 x 12 x 1.4mm LFBGA package
  - -Pb and Halogen Free

#### Overview

The 128Mb DDR SDRAM is a high-speed CMOS double data rate synchronous DRAM containing 128 Mbits. It is internally configured as a quad 1M x 32 DRAM with a synchronous interface (all signals are registered on the positive edge of the clock signal, CK). Data outputs occur at both rising edges of CK and CK. Read and write accesses to the SDRAM are burst oriented; accesses start at a selected location and continue for a programmed number of locations in a programmed sequence. Accesses begin with the registration of a BankActivate command, which is then followed by a Read or Write command. The device provides programmable Read or Write burst lengths of 2, 4, 8. An auto precharge function may be enabled to provide a self-timed row precharge that is initiated at the end of the burst sequence. The refresh functions, either Auto or Self Refresh are easy to use. In addition, 128Mb DDR SDRAM features programmable DLL option. By having a programmable mode register and extended mode register, the system can choose the most suitable modes to maximize its performance. These devices are well suited for applications requiring high memory bandwidth; result in a device particularly well suited to high performance main memory and applications.

#### **Table 1. Ordering Information**

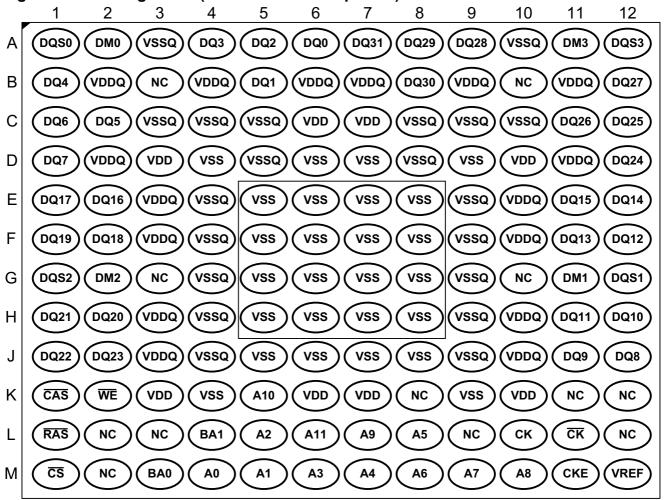
Part Number	Org	Temperature	MaxClock (MHz)	Package
AS4C4M32D1A-5BCN	4Mx32	Commercial 0°C to 70°C	200	144-ball FBGA
AS4C4M32D1A-5BIN	4Mx32	Industrial -40°C to 85°C	200	144-ball FBGA

### **Table 2. Speed Grade Information**

Speed Grade	Clock Frequency	CAS Latency	tRCD (ns)	tRP (ns)
DDR1-400	200MHz	3	15	15



Figure 1. Pin Assignment (LFBGA 144Ball Top View)



Confidential - 3/64 - Rev.1.0 May 2016



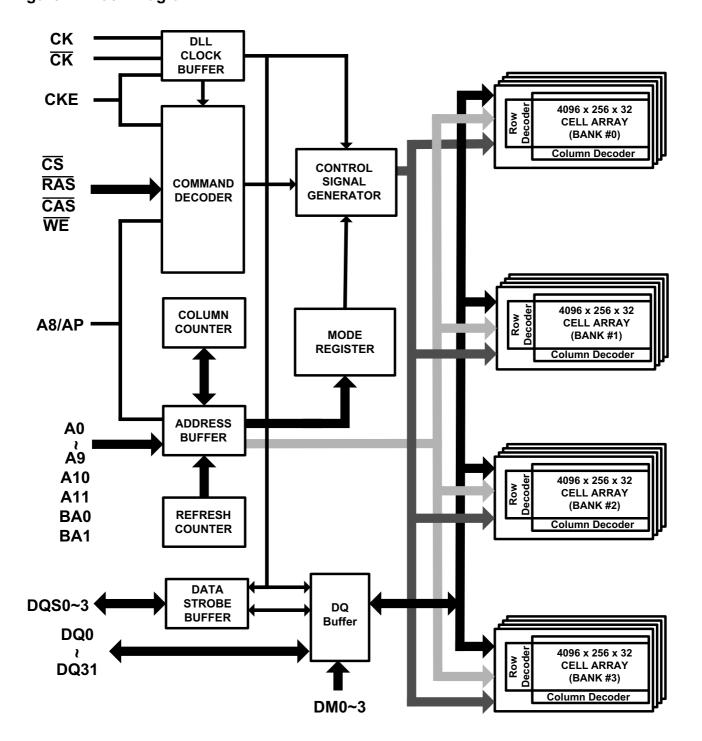
Table 3. Pin Assignment by Name (LFBGA 144Ball)

Symbol	Location	Symbo	Location	n Symbol	Location										
A0	M4	DQ6	C1	DQ24	D12	CK	L10	VDDQ	В6	VSS	E5	VSS	J7	VSSQ	G4
A1	M5	DQ7	D1	DQ25	C12	CK	L11	VDDQ	В7	VSS	E6	VSS	J8	VSSQ	G9
A2	L5	DQ8	J12	DQ26	C11	CKE	M11	VDDQ	В9	VSS	E7	VSS	K4	VSSQ	H4
А3	M6	DQ9	J11	DQ27	B12	CS	M1	VDDQ	B11	VSS	E8	VSS	K9	VSSQ	H9
A4	M7	DQ10	H12	DQ28	A9	RAS	L1	VDDQ	D2	VSS	F5	VSSQ	А3	VSSQ	J4
A5	L8	DQ11	H11	DQ29	A8	CAS	K1	VDDQ	D11	VSS	F6	VSSQ	A10	VSSQ	J9
A6	M8	DQ12	F12	DQ30	В8	WE	K2	VDDQ	E3	VSS	F7	VSSQ	C3	NC	В3
A7	M9	DQ13	F11	DQ31	A7	VREF	M12	VDDQ	E10	VSS	F8	VSSQ	C4	NC	B10
A8/AP	M10	DQ14	E12	DQS0	A1	VDD	C6	VDDQ	F3	VSS	G5	VSSQ	C5	NC	G3
A9	L7	DQ15	E11	DQS1	G12	VDD	C7	VDDQ	F10	VSS	G6	VSSQ	C8	NC	G10
A10	K5	DQ16	E2	DQS2	G1	VDD	D3	VDDQ	Н3	VSS	G7	VSSQ	C9	NC	K8
A11	L6	DQ17	E1	DQS3	A12	VDD	D10	VDDQ	H10	VSS	G8	VSSQ	C10	NC	K11
DQ0	A6	DQ18	F2	DM0	A2	VDD	K3	VDDQ	J3	VSS	H5	VSSQ	D5	NC	K12
DQ1	B5	DQ19	F1	DM1	G11	VDD	K6	VDDQ	J10	VSS	H6	VSSQ	D8	NC	L2
DQ2	A5	DQ20	H2	DM2	G2	VDD	K7	VSS	D4	VSS	H7	VSSQ	E4	NC	L3
DQ3	A4	DQ21	H1	DM3	A11	VDD	K10	VSS	D6	VSS	H8	VSSQ	E9	NC	L9
DQ4	B1	DQ22	J1	BA0	М3	VDDQ	B2	VSS	D7	VSS	J5	VSSQ	F4	NC	L12
DQ5	C2	DQ23	J2	BA1	L4	VDDQ	B4	VSS	D9	VSS	J6	VSSQ	F9	NC	M2

Confidential - 4/64 - Rev.1.0 May 2016



Figure 2. Block Diagram





# **Pin Descriptions**

## **Table 4. Pin Details**

Symbol	Туре	Description
CK, CK	Input	Differential Clock: CK, $\overline{\text{CK}}$ are driven by the system clock. All SDRAM input
		commands are sampled on the positive edge of CK. Both CK and $\overline{\text{CK}}$ increment the
		internal burst counter and controls the output registers.
CKE	Input	Clock Enable: CKE activates (HIGH) and deactivates (LOW) the CK signal. If CKE goes low synchronously with clock, the internal clock is suspended from the next clock cycle and the state of output and burst address is frozen as long as the CKE remains low. When all banks are in the idle state, deactivating the clock controls the entry to the Power Down and Self Refresh modes.
BA0, BA1	Input	<b>Bank Activate:</b> BA0 and BA1 define to which bank the BankActivate, Read, Write, or BankPrecharge command is being applied. They also define which Mode Register or Extended Mode Register is loaded during a Mode Register Set command.
A0-A11	Input	Address Inputs: A0-A11 are sampled during the Bank Activate command (row address A0-A11) and Read/Write command (column address A0-A7 with A8 defining Auto Precharge) to select one location out of the 1M available in the respective bank. During a Precharge command, A8 is sampled to determine if all banks are to be precharged (A8 = HIGH). The address inputs also provide the op-code during a Mode Register Set or Extended Mode Register Set command.
CS	Input	Chip Select: CS enables (sampled LOW) and disables (sampled HIGH) the
		command decoder. All commands are masked when $\overline{CS}$ is sampled HIGH. $\overline{CS}$ provides for external bank selection on systems with multiple banks. It is considered part of the command code.
RAS	Input	Row Address Strobe: The RAS signal defines the operation commands in
10.0		conjunction with the $\overline{\text{CAS}}$ and /WE signals and is latched at the positive edges of CK.
		When $\overline{RAS}$ and $\overline{CS}$ are asserted "LOW" and $\overline{CAS}$ is asserted "HIGH" either the
		BankActivate command or the Precharge command is selected by the WE signal.
		When the WE is asserted "HIGH," the BankActivate command is selected and the
		bank designated by BA is turned on to the active state. When the $\overline{WE}$ is asserted "LOW," the Precharge command is selected and the bank designated by BA is switched to the idle state after the precharge operation.
CAS	Input	Column Address Strobe: The CAS signal defines the operation commands in
		conjunction with the $\overline{RAS}$ and /WE signals and is latched at the positive edges of CK. When /RAS is held "HIGH" and $\overline{CS}$ is asserted "LOW" the column access is started by asserting $\overline{CAS}$ "LOW" Then, the Read or Write command is selected by asserting $\overline{WE}$ "HIGH" or "LOW".
	Innut	
WE	Input	Write Enable: The WE signal defines the operation commands in conjunction with the RAS and CAS signals and is latched at the positive edges of CK. The WE input is used to select the BankActivate or Precharge command and Read or Write command.
DQS0-DQS3	Input / Output	<b>Bidirectional Data Strobe:</b> The DQSx signals are mapped to the following data bytes: DQS0 to DQ0-DQ7, DQS1 to DQ8-DQ15, DQS2 to DQ16-DQ23, and DQS3 to DQ24-DQ31.
DM0 - DM3	Input	<b>Data Input Mask:</b> DM0-DM3 are byte specific. Input data is masked when DM is sampled HIGH during a write cycle. DM3 masks DQ31-DQ24, DM2 masks DQ23-DQ16, DM1 masks DQ15-DQ8, and DM0 masks DQ7-DQ0.
DQ0 - DQ31	Input / Output	<b>Data I/O:</b> The DQ0-DQ31 input and output data are synchronized with positive and negative edges of DQS0~DQS3. The I/Os are byte-maskable during Writes.
V <sub>DD</sub>	Supply	Power Supply: Power for the input buffers and core logic.
Vss	Supply	Ground: Ground for the input buffers and core logic.
VDDQ	Supply	DQ Power: Provide isolated power to DQs for improved noise immunity.



Ī	Vssq	Supply	DQ Ground: Provide isolated ground to DQs for improved noise immunity.
	VREF	Supply	Reference Voltage for Inputs: +0.5 x VDDQ
Ī	NC	-	No Connect: No internal connection, these pins suggest to be left unconnected.

Confidential - 7/64 - Rev.1.0 May 2016



## **Operation Mode**

Table 5 shows the truth table for the operation commands.

## Table 5. Truth Table (Note (1), (2))

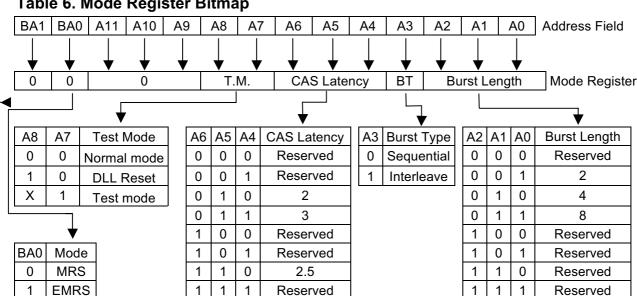
Command	State	CKEn-1	CKEn	DM	BA1	BA0	A8	A11-A9, A7-0	CS	RAS	CAS	WE
BankActivate	Idle <sup>(3)</sup>	Н	Х	Χ	٧	V	Ro	w Address	L	L	Н	Н
BankPrecharge	Any	Н	Χ	Χ	٧	V	L	Х	L	L	Н	L
Precharge All	Any	Ι	Χ	Χ	Χ	Χ	Ι	Χ	L	L	Н	L
Write	Active <sup>(3)</sup>	Ι	Χ	٧	>	>	Ш	0 -	L	Η	L	L
Write and AutoPrecharge	Active <sup>(3)</sup>	Ι	Χ	٧	>	>	Ι	Column Address	L	Η	L	L
Read	Active <sup>(3)</sup>	Η	Χ	Χ	٧	٧	L	Address A0~A7	L	Н	L	Н
Read and Autoprecharge	Active <sup>(3)</sup>	Н	Х	Х	V	V	Н	AO AI	L	Н	L	Н
Mode Register Set	Idle	Н	Х	Χ	L	L	,	)D aada	L	L	L	L
Extended Mode Register Set	Idle	Н	Х	Χ	L	Н	(	OP code	L	L	L	L
No-Operation	Any	Н	Х	Х	Х	Χ	Χ	Х	L	Н	Н	Н
Device Deselect	Any	Н	Х	Χ	Х	Χ	Χ	Х	Н	Х	Χ	Χ
Burst Stop	Active <sup>(4)</sup>	Ι	Χ	Χ	Χ	Χ	Χ	Χ	L	Η	Н	Ш
AutoRefresh	Idle	Η	Н	Χ	Х	Χ	Χ	Х	L	L	L	Н
SelfRefresh Entry	Idle	Н	L	Х	Х	Χ	Χ	Х	L	L	L	Н
SelfRefresh Exit	Idle		Н	Х	Х	Х	Х	Х	Н	Х	Χ	Χ
Selikeliesh Exit	(Self Refresh)	L	П	^	^	^	^	^	L	Н	Н	Н
Davier Davin Made France	1-11- / A -+i: (5)	Н		Х	Х	Х	V	V	Н	Х	Χ	Χ
Power Down Mode Entry	Idle/Active <sup>(5)</sup>	П	L	^	^	Α .	Χ	X	L	Н	Н	Н
Dower Down Made Evit	Any		Н	Х	Х	Х	Х	Х	Н	Х	Χ	Χ
Power Down Mode Exit	(Power Down)	L	П	^	٨	^	^	_ ^	L	Н	Н	Н
Data Mask Enable <sup>(6)</sup>	Active	Н	Х	Н	Χ	Χ	Х	Х	Χ	Х	Х	Χ
Data Mask Disable	Active	Н	Х	L	Χ	Χ	Х	Х	Χ	Х	Х	Χ

- **Note:** 1. V = Valid data, X = Don't Care, L = Low level, H = High level
  - 2. CKEn signal is input level when commands are provided. CKE<sub>n-1</sub> signal is input level one clock cycle before the commands are provided.
  - 3. These are states of bank designated by BA0, BA1signals.
  - 4. Read burst stop with BST command for all burst types.
  - 5. Power Down Mode can not enter in the burst operation. When this command is asserted in the burst cycle, device state is clock suspend mode.
  - 6. DM0 DM3 can be enabled respectively.

Confidential - 8/64 -Rev.1.0 May 2016

### Mode Register Set (MRS)

The Mode Register stores the data for controlling various operating modes of a DDR SDRAM. It programs CAS Latency, Burst Type, and Burst Length to make the DDR SDRAM useful for a variety of applications. The default value of the Mode Register is not defined; therefore the Mode Register must be written by the user. Values stored in the register will be retained until the register is reprogrammed. The Mode Register is written by asserting Low on  $\overline{\text{CS}}$ ,  $\overline{\text{RAS}}$ ,  $\overline{\text{CAS}}$ ,  $\overline{\text{WE}}$ , BA1 and BA0 (the device should have all banks idle with no bursts in progress prior to writing into the mode register, and CKE should be High). The state of address pins A0~A11 and BA0, BA1 in the same cycle in which  $\overline{CS}$ ,  $\overline{RAS}$ ,  $\overline{CAS}$  and  $\overline{WE}$  are asserted Low is written into the Mode Register. A minimum of two clock cycles, tMRD, are required to complete the write operation in the Mode Register. The Mode Register is divided into various fields depending on functionality. The Burst Length uses A0~A2, Burst Type uses A3, and CAS Latency (read latency from column address) uses A4~A6. A logic 0 should be programmed to all the undefined addresses to ensure future compatibility. Reserved states should not be used to avoid unknown device operation or incompatibility with future versions. Refer to the table for specific codes for various burst lengths, burst types and CAS latencies.



**Table 6. Mode Register Bitmap** 

Burst Length Field (A2~A0)

This field specifies the data length of column access using the A2~A0 pins and selects the Burst Length to be 2, 4, and 8.

**Table 7. Burst Length** 

A2	A1	A0	Burst Length
0	0	0	Reserved
0	0	1	2
0	1	0	4
0	1	1	8
1	0	0	Reserved
1	0	1	Reserved
1	1	0	Reserved
1	1	1	Reserved

Confidential - 9/64 -Rev.1.0 May 2016 • Addressing Mode Select Field (A3)

The Addressing Mode can be one of two modes, either Interleave Mode or Sequential Mode. Both Sequential Mode and Interleave Mode support burst length of 2, 4, and 8.

**Table 8. Addressing Mode** 

А3	Addressing Mode
0	Sequential
1	Interleave

Burst Definition, Addressing Sequence of Sequential and Interleave Mode

**Table 9. Burst Address ordering** 

Burst	Sta	art Addre	ess	Cognontial	Interleave
Length	A2	A1	A0	Sequential	interieave
2	Χ	Х	0	0, 1	0, 1
	Χ	Х	1	1, 0	1, 0
	Χ	0	0	0, 1, 2, 3	0, 1, 2, 3
4	Χ	0	1	1, 2, 3, 0	1, 0, 3, 2
4	Χ	1	0	2, 3, 0, 1	2, 3, 0, 1
	Χ	1	1	3, 0, 1, 2	3, 2, 1, 0
	0	0	0	0, 1, 2, 3, 4, 5, 6, 7	0, 1, 2, 3, 4, 5, 6, 7
	0	0	1	1, 2, 3, 4, 5, 6, 7, 0	1, 0, 3, 2, 5, 4, 7, 6
	0	1	0	2, 3, 4, 5, 6, 7, 0, 1	2, 3, 0, 1, 6, 7, 4, 5
8	0	1	1	3, 4, 5, 6, 7, 0, 1, 2	3, 2, 1, 0, 7, 6, 5, 4
8	1	0	0	4, 5, 6, 7, 0, 1, 2, 3	4, 5, 6, 7, 0, 1, 2, 3
	1	0	1	5, 6, 7, 0, 1, 2, 3, 4	5, 4, 7, 6, 1, 0, 3, 2
	1	1	0	6, 7, 0, 1, 2, 3, 4, 5	6, 7, 4, 5, 2, 3, 0, 1
	1	1	1	7, 0, 1, 2, 3, 4, 5, 6	7, 6, 5, 4, 3, 2, 1, 0

CAS Latency Field (A6~A4)

This field specifies the number of clock cycles from the assertion of the Read command to the first read data. The minimum whole value of CAS Latency depends on the frequency of CK. The minimum whole value satisfying the following formula must be programmed into this field.  $t_{CAC}$  (min)  $\leq$  CAS Latency X  $t_{CK}$ 

Table 10. CAS Latency

A6	A5	A4	CAS Latency
0	0	0	Reserved
0	0	1	Reserved
0	1	0	2 clocks
0	1	1	3 clocks
1	0	0	Reserved
1	0	1	Reserved
1	1	0	2.5 clocks
1	1	1	Reserved

Confidential - 10/64 - Rev.1.0 May 2016

• Test Mode Field (A8~A7)

These two bits are used to enter the test mode and must be programmed to "00" in normal operation.

**Table 11. Test Mode** 

A8	A7	Test Mode
0	0	Normal mode
1	0	DLL Reset
X	1	Test mode

• (BA0, BA1)

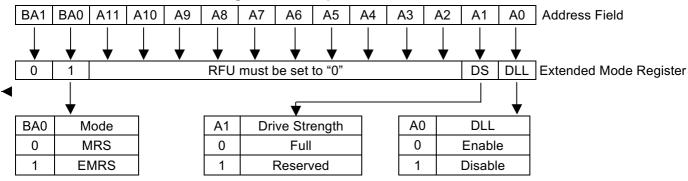
#### Table 12. MRS/EMRS

BA1	BA0	A11 ~ A0
RFU	0	MRS Cycle
RFU	1	Extended Functions (EMRS)

## **Extended Mode Register Set (EMRS)**

The Extended Mode Register Set stores the data for enabling or disabling DLL and selecting output driver strength. The default value of the extended mode register is not defined, therefore must be written after power up for proper operation. The extended mode register is written by asserting low on  $\overline{CS}$ ,  $\overline{RAS}$ ,  $\overline{CAS}$ , and  $\overline{WE}$ . (the device should have all banks idle with no bursts in progress prior to writing into the mode register, and CKE should be High)The state of A0 ~ A11 and BA1 are written in the mode register in the same cycle as  $\overline{CK}$ ,  $\overline{RAS}$ ,  $\overline{CAS}$ , and  $\overline{WE}$  going low. The DDR SDRAM should be in all bank precharge with CKE already high prior to writing into the extended mode register. A1 is used for setting driver strength. Two clock cycles are required to complete the write operation in the extended mode register. The mode register contents can be changed using the same command and clock cycle requirements during operation as long as all banks are in the idle state. A0 is used for DLL enable or disable. "High" on BA0 is used for EMRS. Refer to the table for specific codes.

Table 13. Extended Mode Register Bitmap



Confidential - 11/64 - Rev.1.0 May 2016



**Table 14. Absolute Maximum Rating** 

Symbol	Symbol Item		Rating	Unit	Noto
Symbol			-5	Unit	Note
VIN, VOUT	Input, Output Voltage		- 0.5 ~ V <sub>DDQ</sub> +0.5	V	1,2
$V_{DD}$ , $V_{DDQ}$	<u> </u>		-1 ~ 3.6	V	1,2
	Ambient Temperature	Commercial	0~70	°C	1
TA		Industrial	-40~85	°C	1
Тѕтс	Storage Temperature		- 55~150	°C	1
TSOLDER	Soldering Temperature (10s)		260	°C	1
PD	Power Dissipation		2.0	W	1
los	Short Circuit Output Current		50	mA	1

Note1: Stress greater than those listed under "Absolute Maximum Ratings" may cause permanent damage of the devices

Note2: These voltages are relative to Vss

Table 15. Recommended D.C. Operating Conditions (SSTL\_2 In/Out, TA = -40 ~ 85 °C)

Symbol	Parameter	Min.	Max.	Unit	Note
$V_{DD}$	Power Supply Voltage	2.3	2.7	V	1
VDDQ	Power Supply Voltage(for I/O )	2.3	2.7	V	1
VREF	Input Reference Voltage	0.49 x VDDQ	0.51 x VDDQ	V	
V <sub>TT</sub>	Termination Voltage	V <sub>REF</sub> – 0.04	V <sub>REF</sub> + 0.04	V	
V <sub>IH(DC)</sub>	Input High Voltage	V <sub>REF</sub> + 0.15	V <sub>DDQ</sub> + 0.3	V	
$V_{\text{IL}(DC)}$	Input Low Voltage	Vssq - 0.3	V <sub>REF</sub> - 0.15	V	
IIL	Input Leakage Current	- 2	2	μΑ	
loz	Output Leakage Current	- 5	5	μΑ	
Іон	Output High Current	-16.2	-	mA	Vон = 1.95V
loL	Output Low Current	16.2	-	mA	VoL = 0.35V

Table 16. Capacitance ( $V_{DD} = 2.5V$ , f = 1MHz,  $T_A = 25$  °C)

Symbol	Parameter	Min.	Max.	Unit
C <sub>IN1</sub>	Input Capacitance (CK, $\overline{CK}$ )	1.5	2.5	pF
C <sub>IN2</sub>	Input Capacitance (All other input-only pins)	1.5	2.5	pF
C <sub>I/O</sub>	DM, DQ, DQS Input/Output Capacitance	3.5	4.5	pF

Note: These parameters are guaranteed by design, periodically sampled and are not 100% tested.

**Table 17. Decoupling Capacitance Guide Line** 

Symbol	Parameter	Value	Unit
CDC1	Decouping Capacitance between VDD and Vss	0.1+0.01	μF
C <sub>DC2</sub>	Decouping Capacitance between VDDQ and VSSQ	0.1+0.01	μF

Confidential - 12/64 - Rev.1.0 May 2016



Table 18. D.C. Characteristics (VDD=2.5V ± 0.2V, TA =-40~85°C)

Parameter & Test Condition		-5	
		Max.	Unit
OPERATING CURRENT: One bank; Active-Precharge; tRC=tRC (min); tCκ=tCκ (min); DQ, DM and DQS inputs changing once per clock cycle; Address and control inputs changing once every two clock cycles.	IDD0	210	mA
OPERATING CURRENT: One bank; Active-Read-Precharge; BL=4; tRC=tRC(min); tcK=tcK(min); lout=0mA; Address and control inputs changing once per clock cycle	IDD1	240	mA
PRECHARGE POWER-DOWN STANDBY CURRENT: All banks idle; power-down mode; tck=tck(min); CKE=LOW	IDD2P	75	mA
IDLE STANDBY CURRENT : CKE = HIGH; CS=HIGH(DESELECT); All banks idle; tck=tck(min); Address and control inputs changing once per clock cycle; VIN=VREF for DQ, DQS and DM	IDD2N	100	mA
<b>ACTIVE POWER-DOWN STANDBY CURRENT</b> : one bank active; powerdown mode; CKE=LOW; tcκ=tcκ(min)	IDD3P	75	mA
ACTIVE STANDBY CURRENT: $\overline{CS}$ =HIGH;CKE=HIGH; one bank active; tRC=tRC(max);tCK=tCK(min);Address and control inputs changing once per clock cycle; DQ,DQS,and DM inputs changing twice per clock cycle	IDD3N	220	mA
<b>OPERATING CURRENT BURST READ</b> : BL=2; READs; Continuous burst; one bank active; Address and control inputs changing once per clock cycle; tcκ=tcκ(min); lout=0mA;50% of data changing on every transfer	IDD4R	420	mA
OPERATING CURRENT BURST Write: BL=2; WRITES; Continuous Burst; one bank active; address and control inputs changing once per clock cycle; tck=tck(min); DQ,DQS,and DM changing twice per clock cycle; 50% of data changing on every transfer	IDD4W	420	mA
AUTO REFRESH CURRENT: trc=trfc(min); tck=tck(min)	IDD5	300	mA
SELF REFRESH CURRENT:			
Self Refresh Mode ; CKE≦0.2V;tcк=tcк(min)	IDD6	6	mA
BURST OPERATING CURRENT 4 bank operation:			
Four bank interleaving READs; BL=4;with Auto Precharge; tRC=tRC(min); tcκ=tcκ(min); Address and control inputs change only during Active, READ, or WRITE command	IDD7	570	mA

#### Note:

- 1. Stress greater than those listed under "Absolute Maximum Ratings" may cause permanent damage of the device.
- 2. All voltages are referenced to Vss.
- 3. These parameters depend on the cycle rate and these values are measured by the cycle rate under the minimum value of tck and tRc. Input signals are changed one time during tck.
- 4. Power-up sequence is described in later page.

Confidential - 13/64 - Rev.1.0 May 2016



# Table 19. Electrical Characteristics and Recommended A.C. Operating Conditions ( $V_{DD} = 2.5V \pm 0.2V$ , $T_A = -40 \sim 85$ °C)

Symbol	Parameter		-5		l lmid
Symbol	nbol Parameter		Min.	Max.	Unit
		CL = 2	7.5	12	ns
<b>t</b> cĸ	Clock cycle time	CL = 2.5	6	12	ns
	CL = 3		5	7.5	ns
tсн	Clock high level width	·	0.45	0.55	tcĸ
tcL	Clock low level width		0.45	0.55	tcĸ
<b>t</b> DQSCK	DQS-out access time from CK, $\overline{\text{CK}}$		-0.6	0.6	ns
tac	Output access time from CK, $\overline{\text{CK}}$		-0.7	0.7	ns
togsq	DQS-DQ Skew		-	0.4	ns
trpre	Read preamble		0.9	1.1	tск
trpst	Read postamble		0.4	0.6	tск
togss	CK to valid DQS-in		0.72	1.25	tск
twpres	DQS-in setup time		0	-	ns
twpre	DQS Write preamble		0.25	-	tск
twpst	DQS write postamble		0.4	0.6	tск
<b>t</b> DQSH	DQS in high level pulse width		0.4	-	tcĸ
toqsl	DQS in low level pulse width		0.4	-	tск
tıs	Address and Control input setup time		0.7	-	ns
tıн	Address and Control input hold time		0.7	-	ns
tos	DQ & DM setup time to DQS		0.4	-	ns
tон	DQ & DM hold time to DQS		0.4	-	ns
t <sub>HP</sub>	Clock half period		t <sub>CLMIN</sub> or t <sub>CHMIN</sub>	-	ns
tqн	DQ/DQS output hold time from DQS		t <sub>HP</sub> - t <sub>QHS</sub>	-	ns
trc	Row cycle time		55	-	ns
trfc	Refresh row cycle time		70	-	ns
tras	Row active time		40	100K	ns
trcd	Active to Read or Write delay		15	-	ns
t <sub>RP</sub>	Row precharge time		15	-	ns
trrd	Row active to Row active delay		2	-	tcĸ
twr	Write recovery time		3	-	tcĸ
tmrd	Mode register set cycle time		2	-	tcĸ
tdal	Auto precharge write recovery + Precharge time		t <sub>WR</sub> + t <sub>RP</sub>	-	tcĸ
txsrd	Self refresh exit to read command delay		200	-	tcĸ
tPDEX	Power down exit time		t <sub>CK</sub> + t <sub>IS</sub>	-	ns
trefi	Average Refresh interval time		-	15.6	μS
tipw	Control and Address input pulse width		2.2	-	ns
tDIPW	DQ & DM input pulse width (for each input)		1.75	-	ns
tHZ	Data-out high-impedance window from CK/ CK		-	0.7	ns
tız	Data-out low-impedance window from CK/ CK		-0.7	0.7	ns
$t_{QHS}$	Data Hold Skew Factor	-	0.5	ns	
DVW	Output data valid window		t <sub>QH</sub> - t <sub>DQSQ</sub>	-	ns
txsnr	Exit Self-Refresh to non-Read command		75	-	ns
tccd	CAS# to CAS# Delay time		1	-	tcĸ
toss	DQS falling edge to CK setup time		0.2	-	tcĸ
tosh	DQS falling edge hold time from CK		0.2	-	tcĸ

Confidential - 14/64 - Rev.1.0 May 2016



Table 20. Recommended A.C. Operating Conditions (TA = -40~85 °C, VDD=2.5V ± 0.2V)

Parameter		-5		
		Min.	Max.	Unit
Input High Voltage (AC)	VIH (AC)	VREF + 0.31	-	V
Input Low Voltage (AC)	VIL (AC)	-	VREF – 0.31	V
Input Different Voltage, CK and $\overline{\text{CK}}$ inputs	VID (AC)	0.7	VDDQ + 0.6	V
Input Crossing Point Voltage, CK and $\overline{\text{CK}}$ inputs	V <sub>IX</sub> (AC)	0.5*V <sub>DDQ</sub> -0.2	0.5*V <sub>DDQ</sub> +0.2	٧

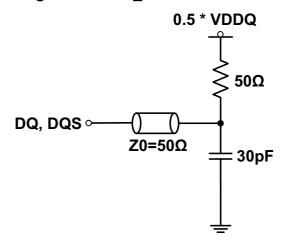
#### Note:

- 1. All voltages are referenced to Vss.
- 2. These parameters depend on the cycle rate and these values are measured by the cycle rate under the minimum value of tck and tRc. Input signals are changed one time during tck.
- 3. Power-up sequence is described in Note 5.
- 4. A.C. Test Conditions

Table 21. SSTL\_2 Interface

Reference Level of Output Signals (VREF)	0.5 * VDDQ
Output Load	Reference to the Test Load
Input Signal Levels	V <sub>REF</sub> +0.31 V / V <sub>REF</sub> -0.31 V
Input Signals Slew Rate	1 V/ns
Reference Level of Input Signals	0.5 * VDDQ

Figure 3. SSTL\_2 A.C. Test Load



Confidential - 15/64 - Rev.1.0 May 2016



#### 5. Power up Sequence

Power up must be performed in the following sequence.

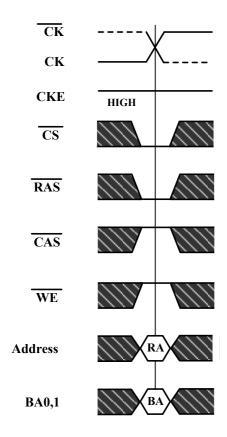
- 1) Apply power to V<sub>DD</sub> before or at the same time as V<sub>DDQ</sub>, V<sub>TT</sub> and V<sub>REF</sub> when all input signals are held "NOP" state and maintain CKE "LOW".
- 2) Start clock and maintain stable condition for minimum 200us.
- 3) Issue a "NOP" command and keep CKE "HIGH"
- 4) Issue a "Precharge All" command.
- 5) Issue EMRS enable DLL.
- 6) Issue MRS reset DLL. (An additional 200 clock cycles are required to lock the DLL).
- 7) Precharge all banks of the device.
- 8) Issue two or more Auto Refresh commands.
- 9) Issue MRS with A8 to low to initialize the mode register.

Confidential - 16/64 - Rev.1.0 May 2016



# **Timing Waveforms**

Figure 4. Activating a Specific Row in a Specific Bank



RA=Row Address BA=Bank Address

Don't Care



Figure 5. tRCD and tRRD Definition

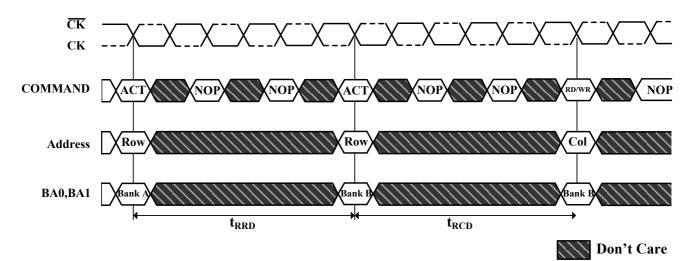
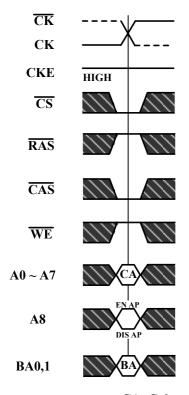


Figure 6. READ Command

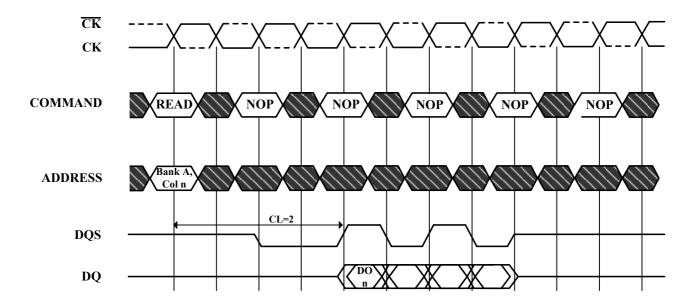


CA=Column Address
BA=Bank Address
EN AP=Enable Autoprecharge
DIS AP=Disable Autoprecharge





Figure 7. Read Burst Required CAS Latencies (CL=2)



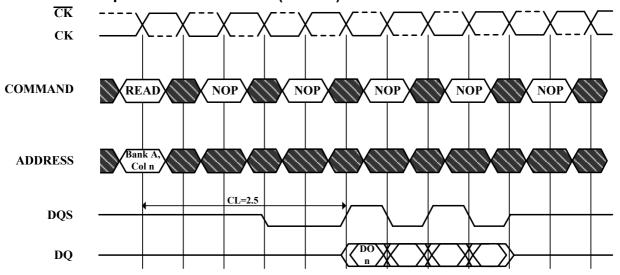
DO n=Data Out from column n

**Burst Length=4** 

3 subsequent elements of Data Out appear in the programmed order following DO n



## Read Burst Required CAS Latencies (CL=2.5)



DO n=Data Out from column n

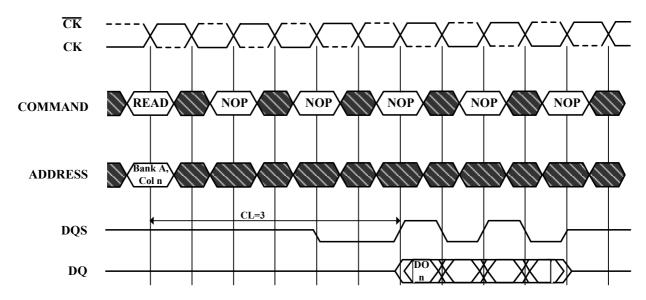
**Burst Length=4** 

3 subsequent elements of Data Out appear in the programmed order following DO n





# Read Burst Required CAS Latencies (CL=3)



DO n=Data Out from column n

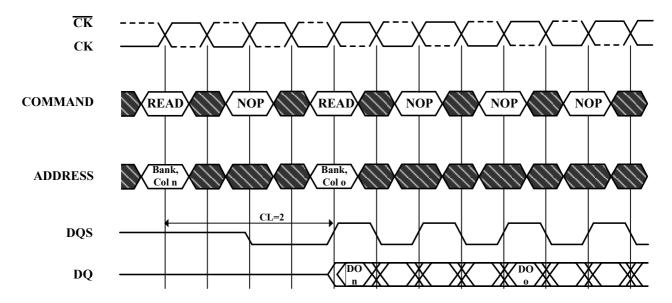
**Burst Length=4** 

3 subsequent elements of Data Out appear in the programmed order following DO  $\boldsymbol{n}$ 





Figure 8. Consecutive Read Bursts Required CAS Latencies (CL=2)



DO n (or o)=Data Out from column n (or column o)

Burst Length=4 or 8 (if 4, the bursts are concatenated; if 8, the second burst interrupts the first)

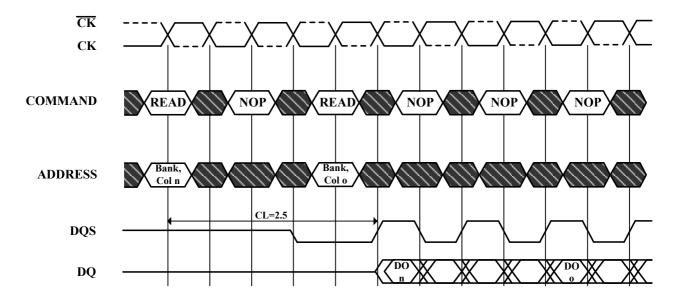
- 3 subsequent elements of Data Out appear in the programmed order following DO n
- 3 (or 7) subsequent elements of Data Out appear in the programmed order following DO o Read commands shown must be to the same device



Confidential - 21/64 - Rev.1.0 May 2016



# Consecutive Read Bursts Required CAS Latencies (CL=2.5)

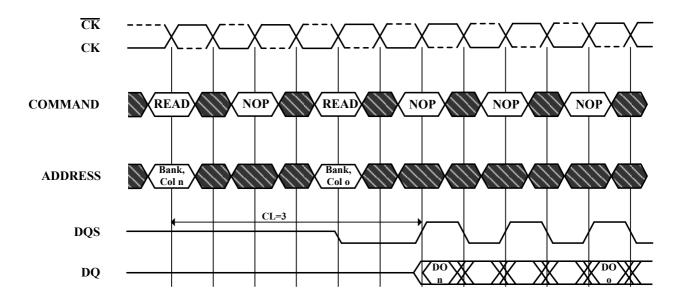


DO n (or o)=Data Out from column n (or column o)
Burst Length=4 or 8 (if 4, the bursts are concatenated; if 8, the second burst interrupts the first)
3 subsequent elements of Data Out appear in the programmed order following DO n
3 (or 7) subsequent elements of Data Out appear in the programmed order following DO o
Read commands shown must be to the same device





# Consecutive Read Bursts Required CAS Latencies (CL=3)

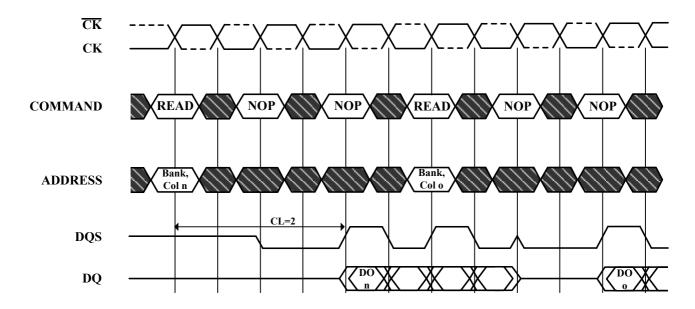


DO n (or o)=Data Out from column n (or column o)
Burst Length=4 or 8 (if 4, the bursts are concatenated; if 8, the second burst interrupts the first)
3 subsequent elements of Data Out appear in the programmed order following DO n
3 (or 7) subsequent elements of Data Out appear in the programmed order following DO o
Read commands shown must be to the same device





Figure 9. Non-Consecutive Read Bursts Required CAS Latencies (CL=2)



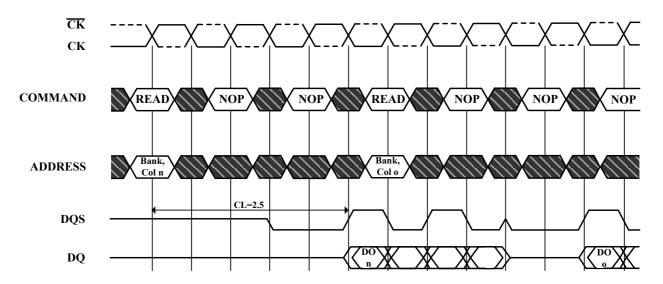
DO n (or o)=Data Out from column n (or column o)

**Burst Length=4** 

3 subsequent elements of Data Out appear in the programmed order following DO n (and following DO o)



## Non-Consecutive Read Bursts Required CAS Latencies (CL=2.5)



DO n (or o)=Data Out from column n (or column o)

Burst Length=4

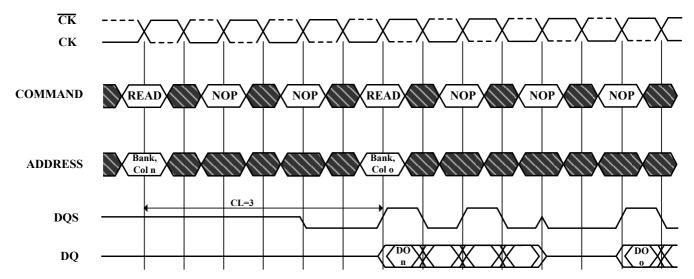
3 subsequent elements of Data Out appear in the programmed order following DO n (and following DO  $\sigma$ )



Confidential - 24/64 - Rev.1.0 May 2016



# Non-Consecutive Read Bursts Required CAS Latencies (CL=3)



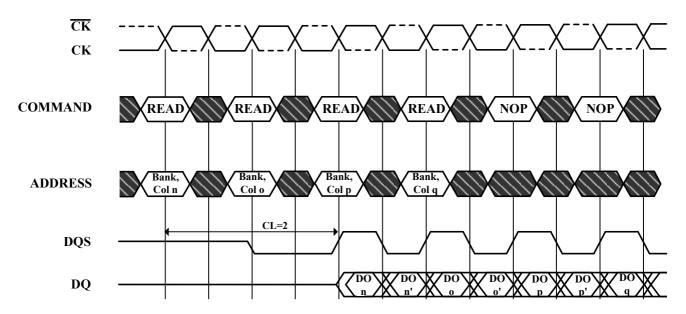
DO n (or o)=Data Out from column n (or column o)

**Burst Length=4** 

3 subsequent elements of Data Out appear in the programmed order following DO n (and following DO  $\sigma$ 



Figure 10. Random Read Accesses Required CAS Latencies (CL=2)

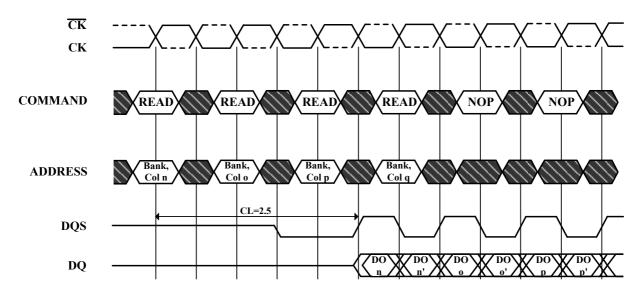


DO n, etc. =Data Out from column n, etc.

n', etc. =the next Data Out following DO n, etc. according to the programmed burst order Burst Length=2,4 or 8 in cases shown. If burst of 4 or 8, the burst is interrupted Reads are to active rows in any banks



## Random Read Accesses Required CAS Latencies (CL=2.5)



DO n, etc. =Data Out from column n, etc.

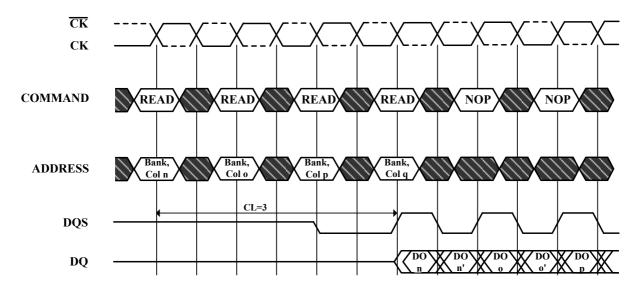
n', etc. =the next Data Out following DO n, etc. according to the programmed burst order Burst Length=2,4 or 8 in cases shown. If burst of 4 or 8, the burst is interrupted Reads are to active rows in any banks



Confidential - 26/64 - Rev.1.0 May 2016



# Random Read Accesses Required CAS Latencies (CL=3)



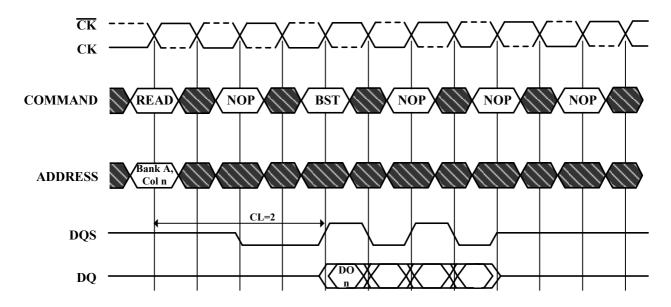
DO n, etc. =Data Out from column n, etc.

n', etc. =the next Data Out following DO n, etc. according to the programmed burst order Burst Length=2,4 or 8 in cases shown. If burst of 4 or 8, the burst is interrupted Reads are to active rows in any banks





Figure 11. Terminating a Read Burst Required CAS Latencies (CL=2)



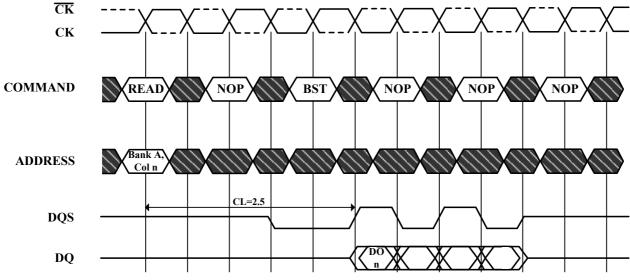
DO n = Data Out from column n

Cases shown are bursts of 8 terminated after 4 data elements

3 subsequent elements of Data Out appear in the programmed order following DO n



## Terminating a Read Burst Required CAS Latencies (CL=2.5)



DO n = Data Out from column n

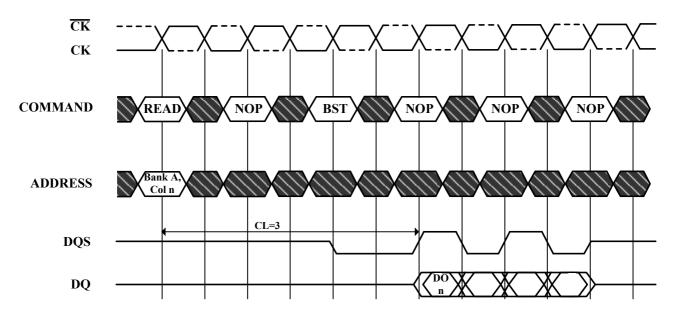
Cases shown are bursts of 8 terminated after 4 data elements

3 subsequent elements of Data Out appear in the programmed order following DO n





# Terminating a Read Burst Required CAS Latencies (CL=3)



DO n = Data Out from column n

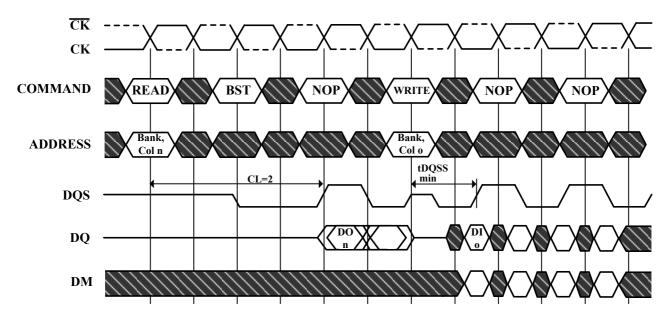
Cases shown are bursts of 8 terminated after 4 data elements

3 subsequent elements of Data Out appear in the programmed order following DO n





Figure 12. Read to Write Required CAS Latencies (CL=2)



DO n (or o)= Data Out from column n (or column o)

Burst Length= 4 in the cases shown (applies for bursts of 8 as well; if burst length is 2, the BST command shown can be NOP)

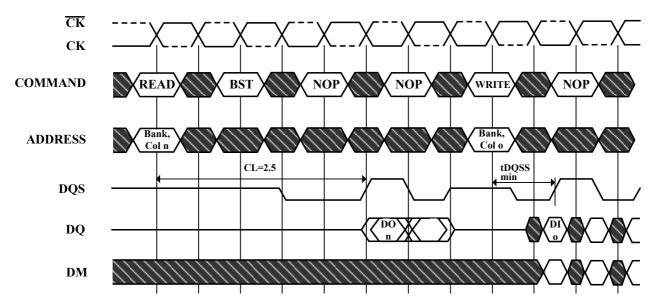
1 subsequent element of Data Out appears in the programmed order following DO n Data in elements are applied following DI o in the programmed order



Confidential - 30/64 - Rev.1.0 May 2016



## Read to Write Required CAS Latencies (CL=2.5)



DO n (or o)= Data Out from column n (or column o)

Burst Length= 4 in the cases shown (applies for bursts of 8 as well; if burst length is 2, the BST command shown can be NOP)

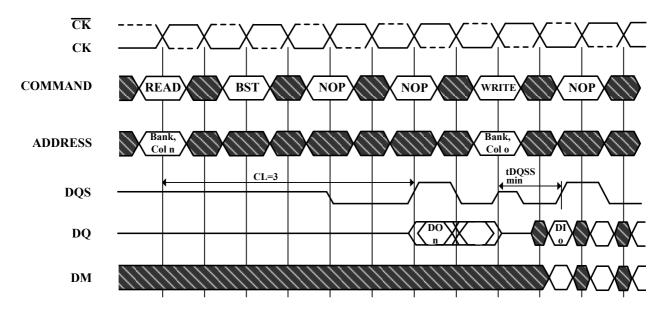
1 subsequent element of Data Out appears in the programmed order following DO n Data in elements are applied following DI o in the programmed order



Confidential - 31/64 - Rev.1.0 May 2016



# Read to Write Required CAS Latencies (CL=3)



DO n (or o)= Data Out from column n (or column o)

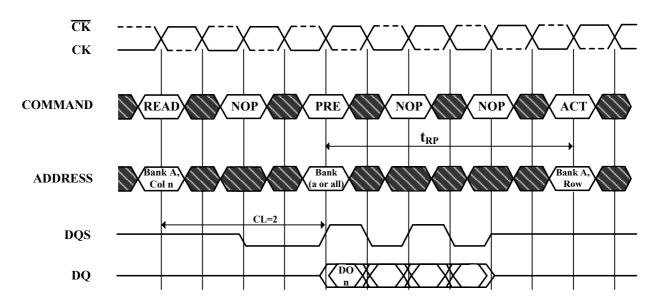
Burst Length= 4 in the cases shown (applies for bursts of 8 as well; if burst length is 2, the BST command shown can be NOP)

1 subsequent element of Data Out appears in the programmed order following DO n Data in elements are applied following DI o in the programmed order





Figure 13. Read to Precharge Required CAS Latencies (CL=2)



DO n = Data Out from column n

Cases shown are either uninterrupted bursts of 4, or interrupted bursts of 8 3 subsequent elements of Data Out appear in the programmed order following DO n

Precharge may be applied at (BL/2) tCK after the READ command Note that Precharge may not be issued before tRAS ns after the ACTIVE command for applicable banks

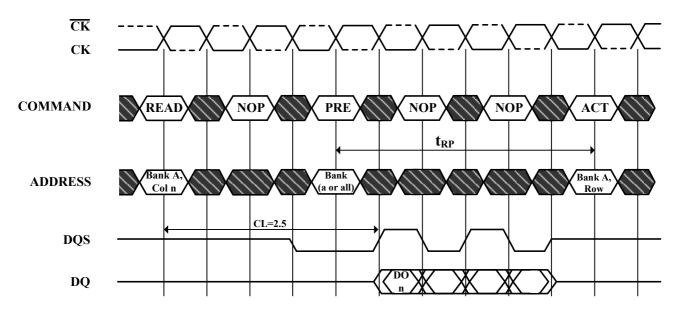
The Active command may be applied if tRC has been met



Confidential - 33/64 - Rev.1.0 May 2016



## Read to Precharge Required CAS Latencies (CL=2.5)



DO n = Data Out from column n

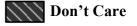
Cases shown are either uninterrupted bursts of 4, or interrupted bursts of 8

3 subsequent elements of Data Out appear in the programmed order following DO  $\boldsymbol{n}$ 

Precharge may be applied at (BL/2) tCK after the READ command

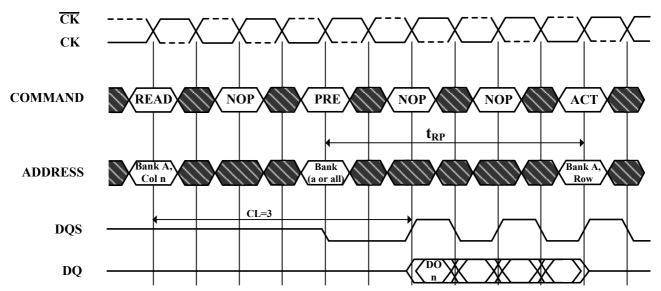
Note that Precharge may not be issued before tRAS ns after the ACTIVE command for applicable banks  $\,$ 

The Active command may be applied if tRC has been met





## Read to Precharge Required CAS Latencies (CL=3)



DO n = Data Out from column n

Cases shown are either uninterrupted bursts of 4, or interrupted bursts of 8 3 subsequent elements of Data Out appear in the programmed order following DO n

Precharge may be applied at (BL/2) tCK after the READ command

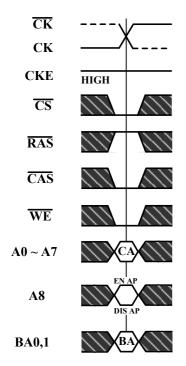
Note that Precharge may not be issued before tRAS ns after the ACTIVE command for applicable banks

The Active command may be applied if tRC has been met





Figure 14. Write Command



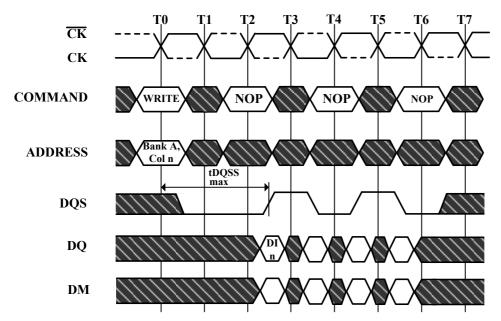
CA=Column Address
BA=Bank Address
EN AP=Enable Autoprecharge
DIS AP=Disable Autoprecharge



Confidential - 36/64 - Rev.1.0 May 2016



### Figure 15. Write Max DQSS



DI n = Data In for column n

 ${\bf 3}$  subsequent elements of Data In are applied in the programmed order following DI  ${\bf n}$ 

A non-interrupted burst of 4 is shown

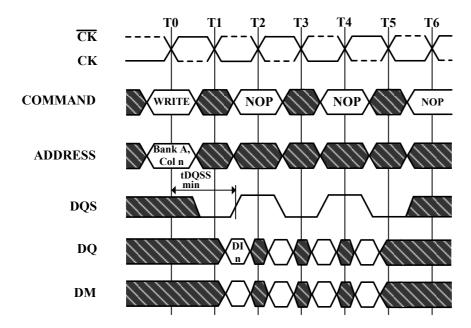
A8 is LOW with the WRITE command (AUTO PRECHARGE disabled)



Confidential - 37/64 - Rev.1.0 May 2016



## Figure 16. Write Min DQSS



DI n = Data In for column n

3 subsequent elements of Data In are applied in the programmed order following DI n

A non-interrupted burst of 4 is shown

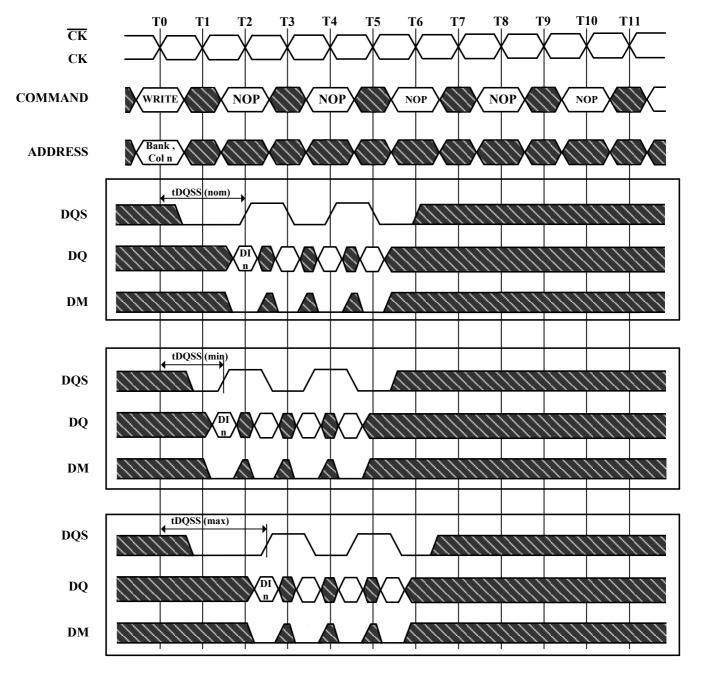
A8 is LOW with the WRITE command (AUTO PRECHARGE disabled)



Confidential - 38/64 - Rev.1.0 May 2016



Figure 17. Write Burst Nom, Min, and Max tDQSS



3 subsequent elements of Data are applied in the programmed order following DI n

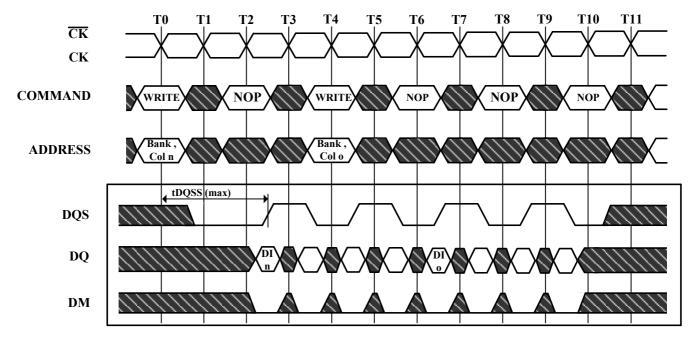
A non-interrupted burst of 4 is shown

A8 is LOW with the WRITE command (AUTO PRECHARGE disabled) DM=DM0  $\sim$  DM3

Don't Care



Figure 18. Write to Write Max tDQSS



3 subsequent elements of Data In are applied in the programmed order following DI n

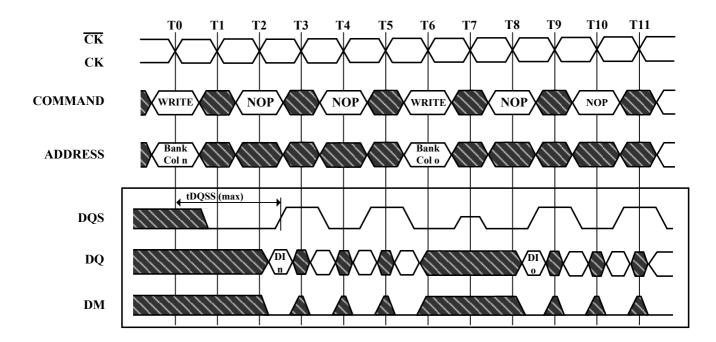
3 subsequent elements of Data In are applied in the programmed order following DI o Non-interrupted bursts of 4 are shown

 $DM = DM0 \sim DM3$ 





Figure 19. Write to Write Max tDQSS, Non Consecutive



3 subsequent elements of Data In are applied in the programmed order following DI n

 ${\bf 3}\ subsequent\ elements\ of\ Data\ \ In\ are\ applied\ in\ the\ programmed\ order\ following\ DI\ o$ 

Non-interrupted bursts of 4 are shown

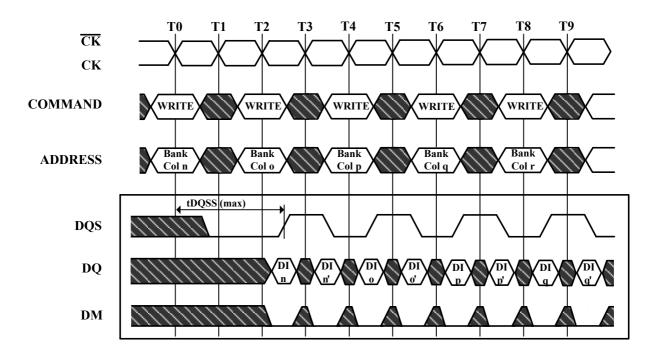
 $DM = DM0 \sim DM3$ 



Confidential - 41/64 - Rev.1.0 May 2016



Figure 20. Random Write Cycles Max tDQSS



n', etc. = the next Data In following DI n, etc. according to the programmed burst order Programmed Burst Length 2, 4, or 8 in cases shown

If burst of 4 or 8, the burst would be truncated

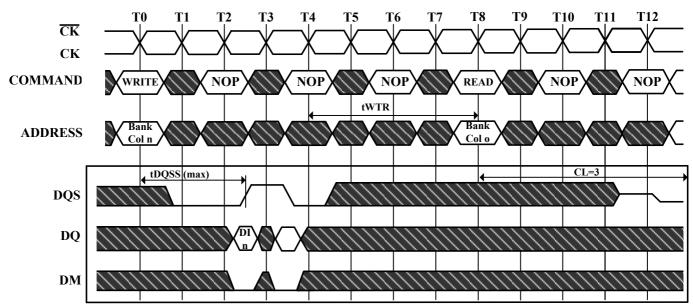
Each WRITE command may be to any bank and may be to the same or different devices  $DM\!=DM0\sim DM3$ 



Confidential - 42/64 - Rev.1.0 May 2016



Figure 21. Write to Read Max tDQSS Non Interrupting



1 subsequent elements of Data In are applied in the programmed order following DI n

A non-interrupted burst of 2 is shown

tWTR is referenced from the first positive CK edge after the last Data In Pair

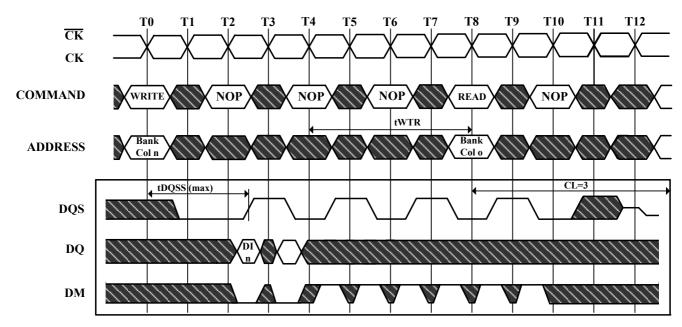
A8 is LOW with the WRITE command (AUTO PRECHARGE is disabled)

The READ and WRITE commands are to the same devices but not necessarily to the same bank  $DM = DM0 \sim DM3$ 

Don't Care



Figure 22. Write to Read Max tDQSS Interrupting



1 subsequent elements of Data In are applied in the programmed order following DI n

An interrupted burst of 8 is shown, 2 data elements are written

tWTR is referenced from the first positive CK edge after the last Data In Pair

A8 is LOW with the WRITE command (AUTO PRECHARGE is disabled)

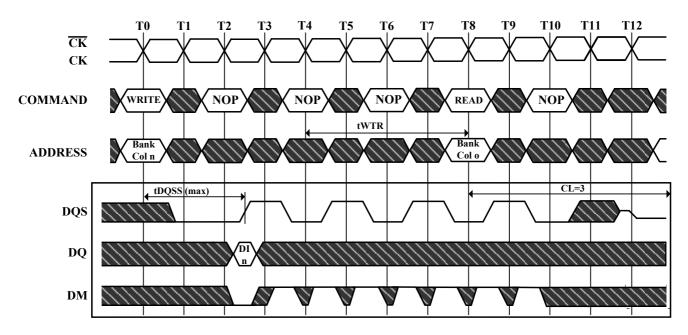
The READ and WRITE commands are to the same devices but not necessarily to the same bank  $DM\!=DM0\sim DM3$ 



Confidential - 44/64 - Rev.1.0 May 2016



Figure 23. Write to Read Max tDQSS, ODD Number of Data, Interrupting



An interrupted burst of 8 is shown, 1 data elements are written

tWTR is referenced from the first positive CK edge after the last Data In Pair (not the last desired Data In element)

A8 is LOW with the WRITE command (AUTO PRECHARGE is disabled)

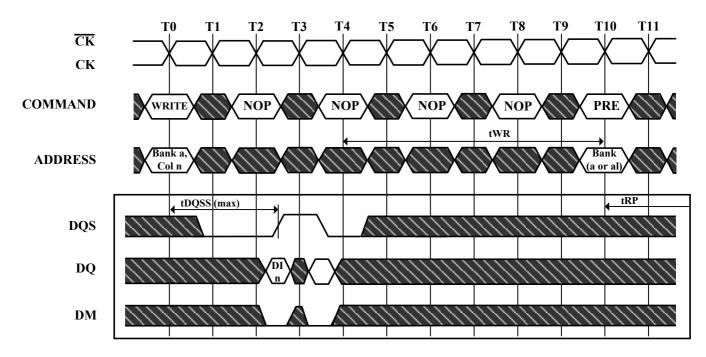
The READ and WRITE commands are to the same devices but not necessarily to the same bank  $DM = DM0 \sim DM3$ 



Confidential - 45/64 - Rev.1.0 May 2016



Figure 24. Write to Precharge Max tDQSS, NON-Interrupting



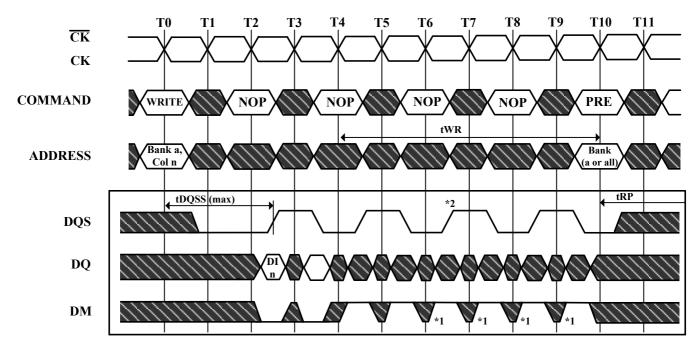
1 subsequent elements of Data In are applied in the programmed order following DI n A non-interrupted burst of 2 is shown

tWR is referenced from the first positive CK edge after the last Data In Pair A8 is LOW with the WRITE command (AUTO PRECHARGE is disabled)  $DM=DM0\sim DM3$ 





Figure 25. Write to Precharge Max tDQSS, Interrupting



An interrupted burst of 4 or 8 is shown, 2 data elements are written tWR is referenced from the first positive CK edge after the last Data In Pair A8 is LOW with the WRITE command (AUTO PRECHARGE is disabled)

\*1 = can be don't care for programmed burst length of 4

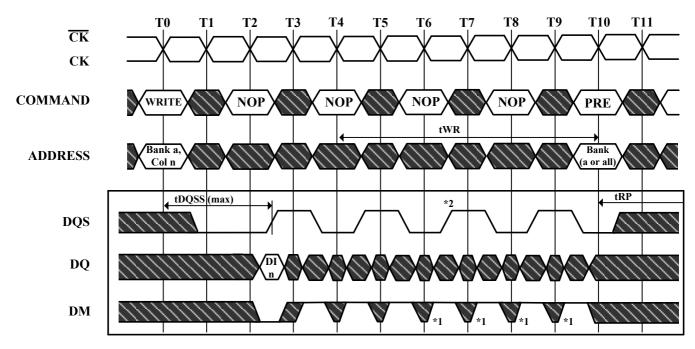
\*2 = for programmed burst length of 4, DQS becomes don't care at this point  $DM = DM0 \sim DM3$ 



Confidential - 47/64 - Rev.1.0 May 2016



Figure 26. Write to Precharge Max tDQSS ODD Number of Data Interrupting



An interrupted burst of 4 or 8 is shown, 1 data element is written tWR is referenced from the first positive CK edge after the last Data In Pair

A8 is LOW with the WRITE command (AUTO PRECHARGE is disabled)

\*1 = can be don't care for programmed burst length of 4

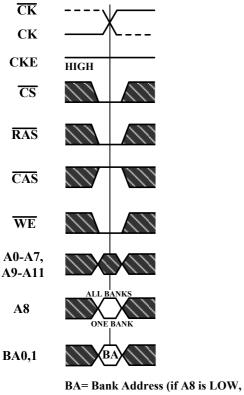
\*2 = for programmed burst length of 4, DQS becomes don't care at this point DM= DM0  $\sim$  DM3



Confidential - 48/64 - Rev.1.0 May 2016



Figure 27. Precharge Command



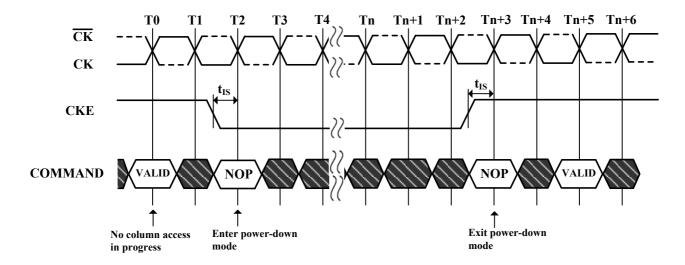
otherwise don't care)



Confidential - 49/64 - Rev.1.0 May 2016

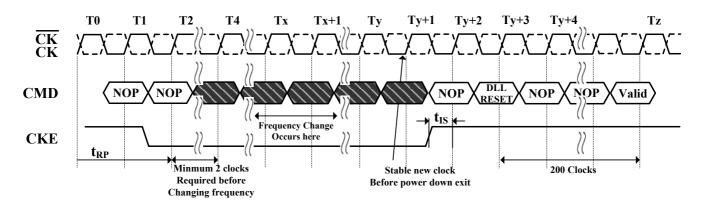


Figure 28. Power-Down



Don't Care

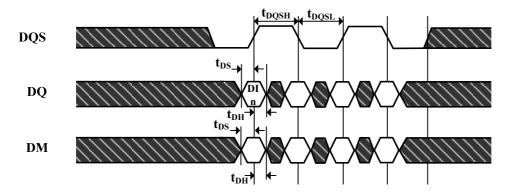
Figure 29. Clock Frequency Change in Precharge



Confidential - 50/64 - Rev.1.0 May 2016



Figure 30. Data input (Write) Timing

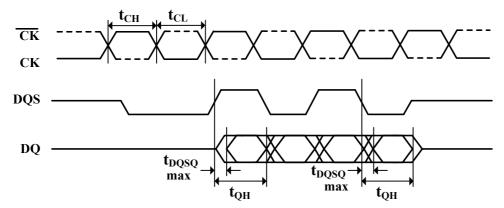


**Burst Length = 4 in the case shown** 

3 subsequent elements of Data In are applied in the programmed order following DI  $\boldsymbol{n}$ 

Don't Care

Figure 31. Data Output (Read) Timing

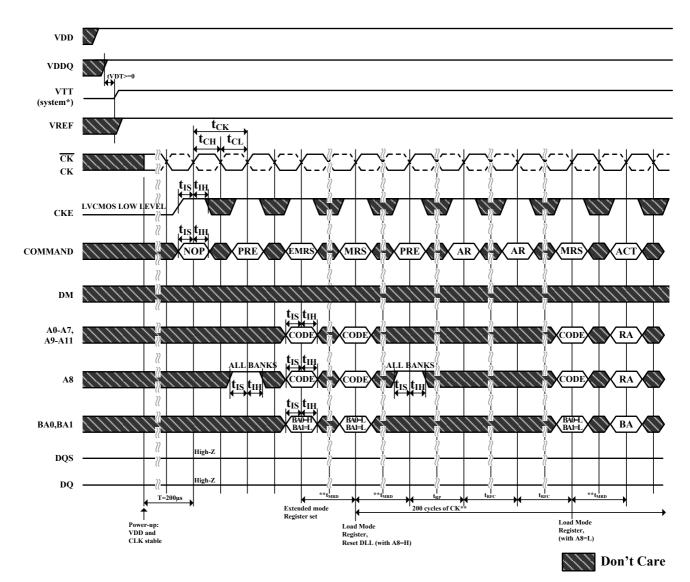


**Burst Length = 4 in the case shown** 

Confidential - 51/64 - Rev.1.0 May 2016



Figure 32. Initialize and Mode Register Sets



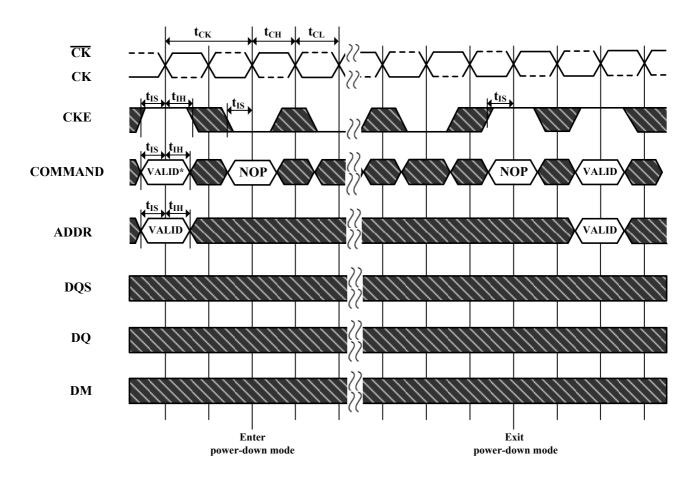
\*=VTT is not applied directly to the device, however tVTD must be greater than or equal to zero to avoid device latch-up.

\*\*= tMRD is required before any command can be applied, and 200 cycles of CK are required before any executable command can be applied the two auto Refresh commands may be moved to follow the first MRS but precede the second PRECHARGE ALL command.

Confidential - 52/64 - Rev.1.0 May 2016



Figure 33. Power Down Mode

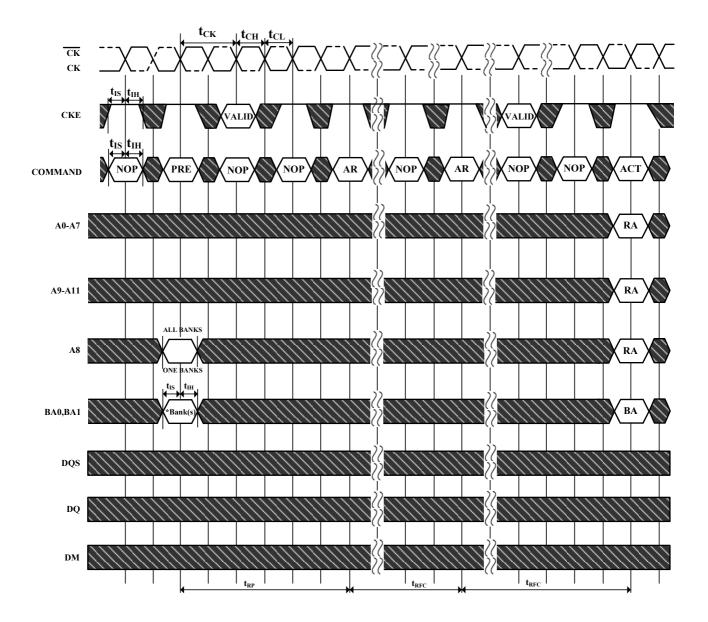


No column accesses are allowed to be in progress at the time Power-Down is entered \*=If this command is a PRECHARGE ALL (or if the device is already in the idle state) then the Power-Down mode shown is Precharge Power Down. If this command is an ACTIVE (or if at least one row is already active) then the Power-Down mode shown is active Power Down.



Confidential - 53/64 - Rev.1.0 May 2016

Figure 34. Auto Refresh Mode



\* = " Don't Care", if A8 is HIGH at this point; A8 must be HIGH if more than one bank is active (i.e., must precharge all active banks)

PRE = PRECHARGE, ACT = ACTIVE, RA = Row Address, BA = Bank Address, AR = AUTOREFRESH

NOP commands are shown for ease of illustration; other valid commands may be possible after tRFC

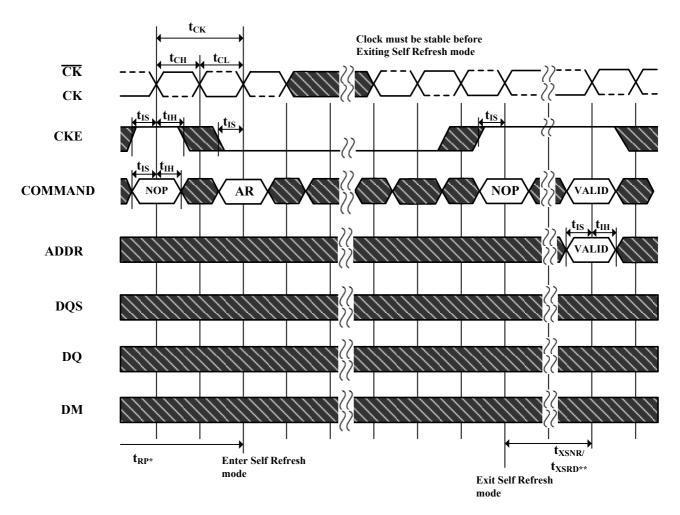
DM, DQ and DQS signals are all " Don't Care" /High-Z for operations shown



Confidential - 54/64 - Rev.1.0 May 2016



Figure 35. Self Refresh Mode



<sup>\* =</sup> Device must be in the " All banks idle" state prior to entering Self Refresh mode

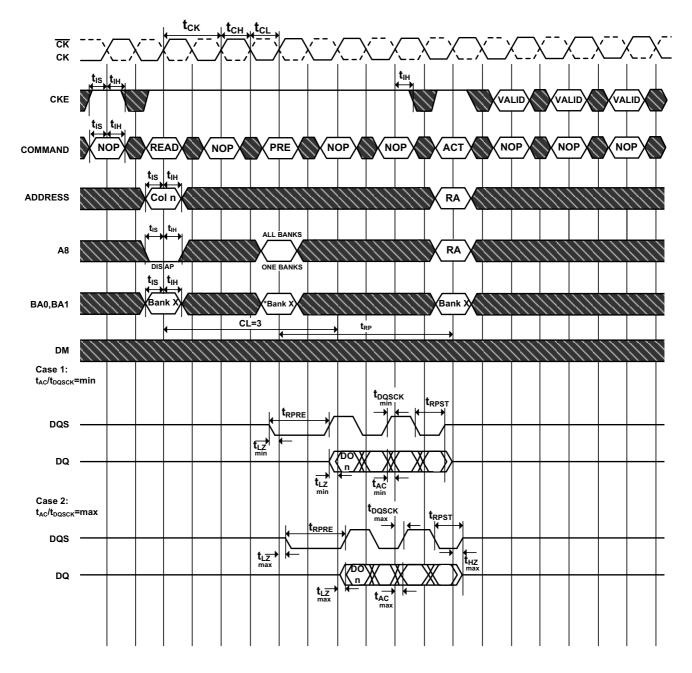
<sup>\*\* =</sup> tXSNR is required before any non-READ command can be applied, and tXSRD (200 cycles of CK) is required before a READ command can be applied.



Confidential - 55/64 - Rev.1.0 May 2016



Figure 36. Read without Auto Precharge



DO n = Data Out from column n

Burst Length = 4 in the case shown

3 subsequent elements of Data Out are provided in the programmed order following DO n

DIS AP = Disable Autoprecharge

\* =" Don't Care", if A8 is HIGH at this point

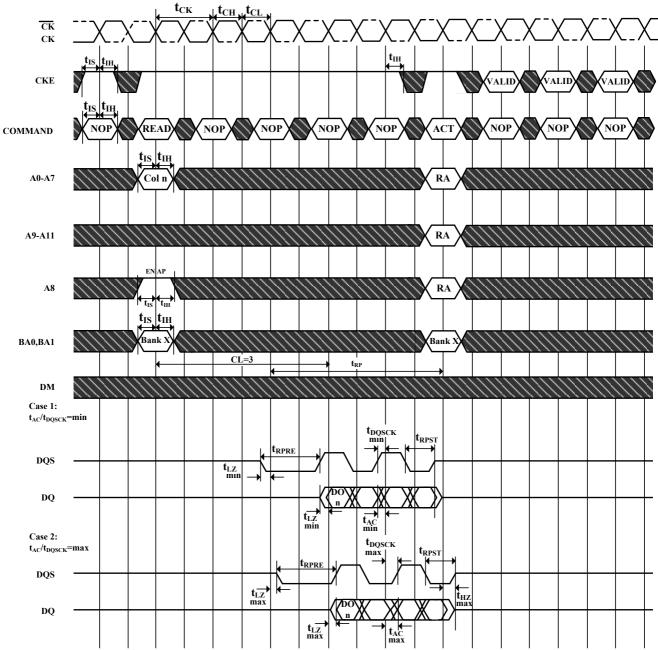
PRE = PRECHARGE, ACT = ACTIVE, RA = Row Address, BA = Bank Address, AR = AUTOREFRESH NOP commands are shown for ease of illustration; other commands may be valid at these times

Precharge may not be issued before tRAS ns after the ACTIVE command for applicable banks





Figure 37. Read with Auto Precharge



DO n = Data Out from column n

Burst Length = 4 in the case shown

3 subsequent elements of Data Out are provided in the programmed order following DO  $\ensuremath{n}$ 

EN AP = Enable Autoprecharge

ACT = ACTIVE, RA = Row Address

NOP commands are shown for ease of illustration; other commands may be valid at these times

The READ command may not be issued until tRAP has been satisfied. If Fast Autoprecharge is supported, tRAP = tRCD, else the READ may not be issued prior to tRASmin - (BL\*tCK/2)

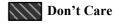
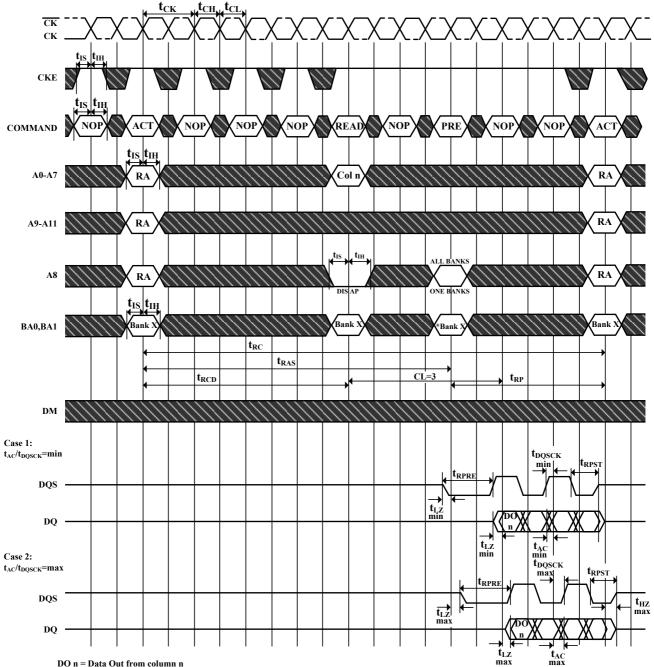




Figure 38. Bank Read Access



DO n = Data Out from column n

Burst Length = 4 in the case shown

3 subsequent elements of Data Out are provided in the programmed order following DO n

DIS AP = Disable Autoprecharge

\* = " Don't Care", if A8 is HIGH at this point

 $PRE = PRECHARGE, ACT = ACTIVE, RA = Row\ Address, BA = Bank\ Address$ 

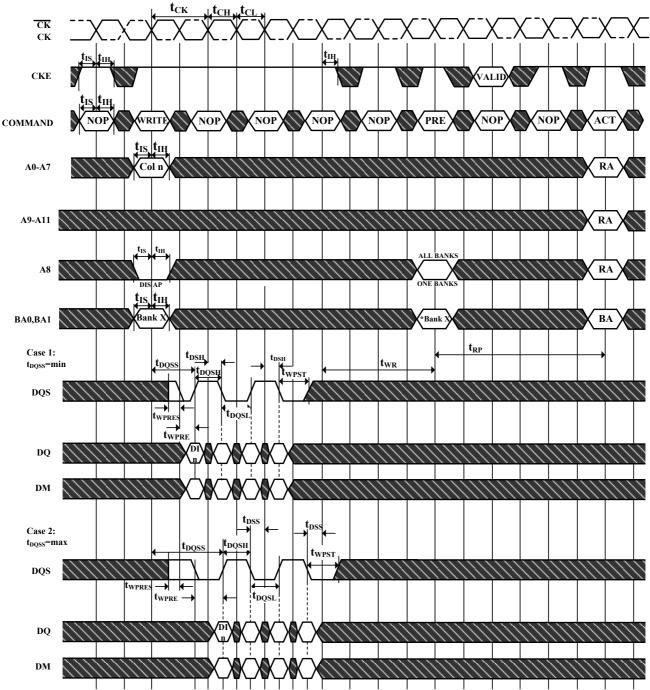
 $NOP\ commands\ are\ shown\ for\ ease\ of\ illustration;\ other\ commands\ may\ be\ valid\ at\ these\ times$ 

Note that  $tRCD > tRCD \ MIN$  so that the same timing applies if Autoprecharge is enabled (in which case tRAS would be limiting)





Figure 39. Write without Auto Precharge



Burst Length = 4 in the case shown

3 subsequent elements of Data In are provided in the programmed order following DI  $\boldsymbol{n}$ 

DIS AP = Disable Autoprecharge

\*=" Don't Care", if A8 is HIGH at this point

PRE = PRECHARGE, ACT = ACTIVE, RA = Row Address, BA = Bank Address, AR = AUTOREFRESH

 $NOP\ commands\ are\ shown\ for\ ease\ of\ illustration;\ other\ commands\ may\ be\ valid\ at\ these\ times$ 

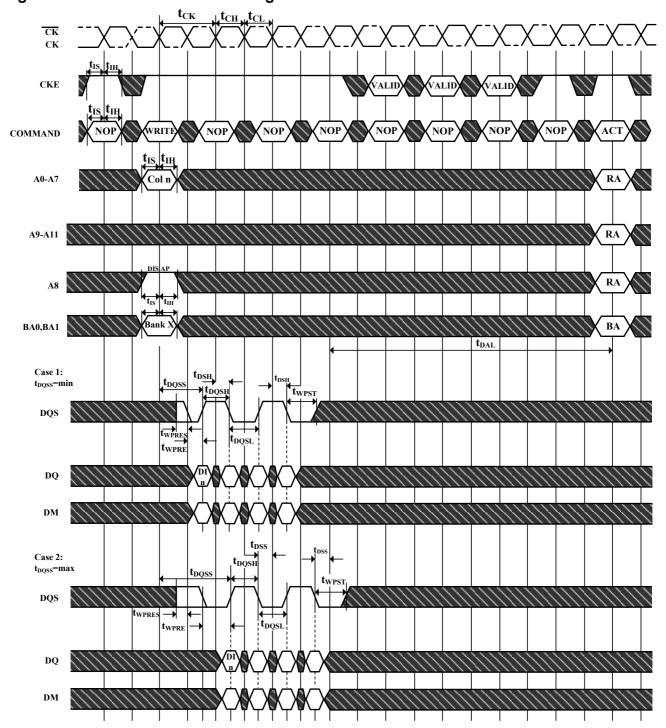
Although tDQSS is drawn only for the first DQS rising edge, each rising edge of DQS must fall within the  $\pm$  25% window of the corresponding positive clock edge

Precharge may not be issued before tRAS ns after the ACTIVE command for applicable banks

**Don't Care** 



Figure 40. Write with Auto Precharge



Burst Length = 4 in the case shown

3 subsequent elements of Data Out are provided in the programmed order following DI  $\boldsymbol{n}$ 

EN AP = Enable Autoprecharge

ACT = ACTIVE, RA = Row Address, BA = Bank Address

 $NOP\ commands\ are\ shown\ for\ ease\ of\ illustration;\ other\ commands\ may\ be\ valid\ at\ these\ times$ 

Although tDQSS is drawn only for the first DQS rising edge, each rising edge of DQS must fall within the  $\pm\,25\%$  window of the corresponding positive clock edge

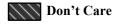
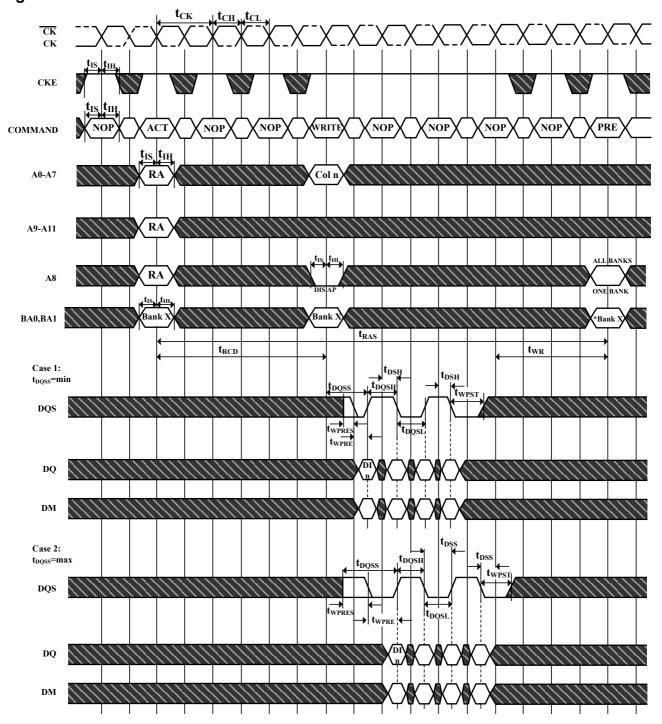




Figure 41. Bank Write Access



Burst Length = 4 in the case shown

3 subsequent elements of Data Out are provided in the programmed order following DI  $\boldsymbol{n}$ 

DIS AP = Disable Autoprecharge

\*=" Don't Care", if A8 is HIGH at this point

PRE = PRECHARGE, ACT = ACTIVE, RA = Row Address, BA = Bank Address

 $NOP\ commands\ are\ shown\ for\ ease\ of\ illustration;\ other\ commands\ may\ be\ valid\ at\ these\ times$ 

Although tDQSS is drawn only for the first DQS rising edge, each rising edge of DQS must fall within the  $\pm\,25\%$  window of the corresponding positive clock edge

Precharge may not be issued before tRAS ns after the ACTIVE command for applicable banks

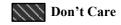
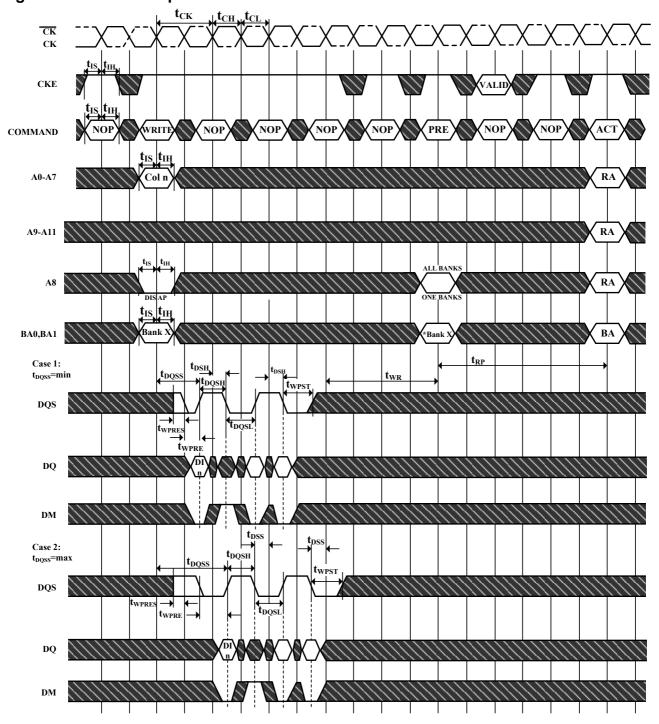




Figure 42. Write DM Operation



Burst Length = 4 in the case shown

 $\boldsymbol{3}$  subsequent elements of Data In are provided in the programmed order following DI  $\boldsymbol{n}$ 

DIS AP = Disable Autoprecharge

\*=" Don't Care", if A8 is HIGH at this point

 $PRE = PRECHARGE, ACT = ACTIVE, RA = Row\ Address, BA = Bank\ Address$ 

NOP commands are shown for ease of illustration; other commands may be valid at these times

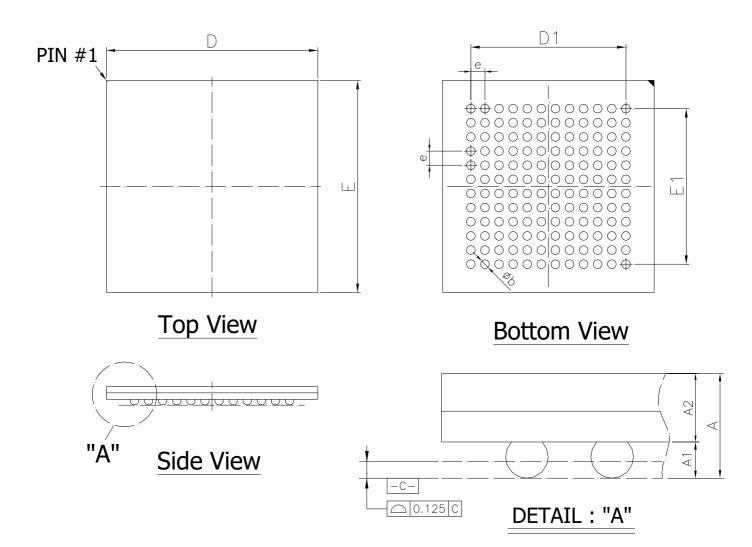
Although tDQSS is drawn only for the first DQS rising edge, each rising edge of DQS must fall within the  $\pm\,25\%$  window of the corresponding positive clock edge

Precharge may not be issued before tRAS ns after the ACTIVE command for applicable banks





Figure 43. 144 ball LFBGA Package Outline Drawing Information Units: mm



Symbol	Dimension in inch			Dimension in mm		
	Min	Nom	Max	Min	Nom	Max
<u>A</u>			0.055			1.40
A1	0.012	0.014	0.016	0.30	0.35	0.40
A2	0.036	0.038	0.040	0.91	0.96	1.01
D	0.469	0.472	0.476	11.90	12.00	12.10
Е	0.469	0.472	0.476	11.90	12.00	12.10
D1	-	0.346	-	-	8.80	
E1	-	0.346		-	8.80	
е		0.031			0.80	
b	0.016	0.018	0.020	0.40	0.45	0.50



# AS4C4M32D1A-5BIN AS4C4M32D1A-5BCN

#### PART NUMBERING SYSTEM

AS4C	4M32D1A	5	В	C/I	N
DRAM	4M32=4Mx32 D1=DDR1 A= A die version	5=200MHz	B = FBGA	C= Commercial (0° C $^{2}$ 70° C) I= Industrial (-40° C $^{2}$ 85° C)	Indicates Pb and Halogen Free



Alliance Memory, Inc. 511 Taylor Way, San Carlos, CA 94070 Tel: 650-610-6800 Fax: 650-620-9211 www.alliancememory.com

Copyright © Alliance Memory All Rights Reserved

© Copyright 2007 Alliance Memory, Inc. All rights reserved. Our three-point logo, our name and Intelliwatt are trademarks or registered trademarks of Alliance. All other brand and product names may be the trademarks of their respective companies. Alliance reserves the right to make changes to this document and its products at any time without notice. Alliance assumes no responsibility for any errors that may appear in this document. The data contained herein represents Alliance's best data and/or estimates at the time of issuance. Alliance reserves the right to change or correct this data at any time, without notice. If the product described herein is under development, significant changes to these specifications are possible. The information in this product data sheet is intended to be general descriptive information for potential customers and users, and is not intended to operate as, or provide, any quarantee or warrantee to any user or customer. Alliance does not assume any responsibility or liability arising out of the application or use of any product described herein, and disclaims any express or implied warranties related to the sale and/or use of Alliance products including liability or warranties related to fitness for a particular purpose, merchantability, or infringement of any intellectual property rights, except as express agreed to in Alliance's Terms and Conditions of Sale (which are available from Alliance). All sales of Alliance products are made exclusively according to Alliance's Terms and Conditions of Sale. The purchase of products from Alliance does not convey a license under any patent rights, copyrights; mask works rights, trademarks, or any other intellectual property rights of Alliance or third parties. Alliance does not authorize its products for use as critical components in life-supporting systems where a malfunction or failure may reasonably be expected to result in significant injury to the user, and the inclusion of Alliance products in such life-supporting systems implies that the manufacturer assumes all risk of such use and agrees to indemnify Alliance against all claims arising from such use.

Confidential - 64/64 - Rev.1.0 May 2016

# **Mouser Electronics**

**Authorized Distributor** 

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

## **Alliance Memory:**

<u>AS4C4M32D1-5BINTR</u> <u>AS4C4M32D1-5BCN</u> <u>AS4C4M32D1-5BIN</u> <u>AS4C4M32D1-5BCNTR</u> <u>AS4C4M32D1A-5BINTR</u> <u>AS4C4M32D1A-5BCNTR</u> <u>AS4C4M32D1A-5BINTR</u>